



**Southern Ohio/Kentucky Section 1132**  
**Matthew Denslow, Section Coordinator**  
**Hosted By: Bionetics Corporation**

*November 14, 2007*

The Mid-West Region Southern Ohio/Kentucky Section 1132 held its first meeting since 2005 on November 14, 2007 in the Concord Room of the Courtyard by Marriott in Newark, Ohio. Hosted by The Bionetics Corporation (operators of the Air Force Primary Standards Laboratory) the attendees were treated to breakfast and a full day of good information and fun.

The meeting was a success with 41 attendees from around the region. In special attendance were Mr. Peter Buzzard, NCSLI Division Vice President Northeastern US; Mr. Lloyd Baker, Regional Coordinator Mid-Western US; Ms. Karen Semer, Director, NCSLI Conference Technical Program; Dr. Klaus Jaeger, Jaeger Enterprises; Ms. Helga Alexander, Chair 161 Training Resources Committee and Mr. Mike Cadenhead, the new Chair for 142 Measurement Comparison Committee. The attendees were treated to a meeting program that included both management and measurement subjects.

Headlining the presentations was Mr. Buzzard who provided an update to the recent Board of Directors meeting. Mr. Baker provided the NCSLI appointment and introduced me as the new Southern Ohio/ Kentucky Section Coordinator.

Our program continued with Dr. Jaeger presenting tutorial results from the 2007 NCSLI Conference in St. Paul, MN.

Next, Dr. Ron Jacobs from The Ohio State University's Center on Education and Training for Employment presented "Developing Employee Expertise through Structured On-the-Job Training." This topic stressed the importance of a properly documented training program to employee development.

Ms. Alexander then provided an update on the Training Resources committee which included an introduction to the Regional Training Event (RTE) concept. The goal of RTEs are to make high quality metrology training in the form of tutorial or seminar style courses available (1) at a more frequent basis than

just the annual NCSLI conference, (2) at a more affordable cost (decreased travel costs), (3) to a larger number of individuals working in metrology, and to individuals who may not have the opportunity to travel to the annual conference, (4) covering topics that are of specific interest to NCSLI members in a particular geographic region.

Mr. Cadenhead presented the activities of the Measurement Comparison committee restating its goals and objectives. The committee is reviewing and updating *NCSLI Recommended Practice 15* "Recommended Practices for Inter-Laboratory Comparisons." He also solicited for participants.

During the technical portion of our meeting, Mr. Tom Hayden, Keithley Instruments, Inc. discussed making accurate low-level electrical measurements using Source Meters or SMUs.

We closed the meeting with a number of door prizes. The next section meeting is planned for April 2008; date and location to be determined. ■

*matthew.denslow@afmetcal.af.mil*